

Product Change Notification / RMES-23FLBS013

Date:

01-Jul-2022

Product Category:

8-bit Microcontrollers

PCN Type:

Manufacturing Change

Notification Subject:

CCB 3296.002 Final Notice: Qualification of MTAI as a new assembly site for selected ATMEGA1284x, ATMEGA16xxx, ATMEGA32xxx, ATMEGA644xx and ATMEGA85x5x device families available in 44L TQFP (10x10x1mm) package.

Affected CPNs:

RMES-23FLBS013_Affected_CPN_07012022.pdf RMES-23FLBS013_Affected_CPN_07012022.csv

Notification Text:

PCN Status: Final Notification

PCN Type:Manufacturing Change

Microchip Parts Affected:Please open one of the files found in the Affected CPNs section. Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

Description of Change:Qualification of MTAI as a new assembly site for selected ATMEGA1284x, ATMEGA16xxx, ATMEGA32xxx, ATMEGA644xx and ATMEGA85x5x device families available in 44L TQFP (10x10x1mm) package.

Pre and Post Change Summary:

	Pre Change	Post Change		
Assembly Site	Lingsen Precision Industries, LTD. (LPI)	Microchip Technology Thailand (HQ (MTAI)		
Wire Material	CuPdAu or Au	Au		
Die Attach Material	CRM-1033BF	3280		
Molding Compound Material	G700	G700		
Lead-Frame Material	C7025	C7025		
Lead-Frame Paddle Size	160x160 or 205x205 or 275x275	180x180 or 275x275		
DAP Surface Prep	Ag plated	Bare Cu		
Tray Comparison	Black Tray (Bakeable)	Black Tray (Bakeable) or Blue Tray (Non-Bakeable)		
	See attached Pre and Post Change comparison			
Moisture Sensitivity Level				
(MSL)	MSL 3	MSL 1		
Classification Level				

Impacts to Data Sheet:None

Change ImpactNone

Reason for Change:To improve manufacturability and on-time delivery performance by qualifying MTAI as a new assembly site.

Change Implementation Status: In progress

Estimated First Ship Date: July 15, 2022 (date code: 2229)

Note: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

	June 2022				July 2022					
Workweek	2 3	2 4	2 5	2 6	2 7	2 8	2 9	3 0	3 1	3 2
Qual Report				х						

Availability						
Final PCN Issue		v				
Date		Х				
Estimated						
Implementation				х		
Date						

Method to Identify Change: Traceability code

Qualification Report:Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:

June 24, 2022: Issued final notification. Attached is the qualification report and provided estimated first ship date by July 15, 2022.

July 01, 2022: Re-issued final notification. Added MSL Classification Level and Tray comparison in Pre and Post change summary table. Added attachment file (ppt) for Tray comparison.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

PCN_RMES-23FLBS013_Pre and Post Change_Summary.pdf PCN_RMES-23FLBS013_Qual Report.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

Terms and Conditions:

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our PCN home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the PCN FAQ section.

If you wish to <u>change your PCN profile, including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections. RMES-23FLBS013 - CCB 3296.002 Final Notice: Qualification of MTAI as a new assembly site for selected ATMEGA1284x, ATMEGA16xxx, ATMEGA32xxx, ATMEGA644xx and ATMEGA85x5x device families available in 44L TQFP (10x10x1mm) package.

Affected Catalog Part Numbers (CPN)

ATMEGA644PA-AN ATMEGA644PA-ANR ATMEGA644-20AU ATMEGA644V-10AU ATMEGA644-20AUR ATMEGA644V-10AUR ATMEGA324PV-10AU ATMEGA324P-20AU ATMEGA324P-20AQR ATMEGA324P-20AUR ATMEGA644PV-10AU ATMEGA644P-20AU ATMEGA644PV-10AQ ATMEGA644PV-10AQR ATMEGA644PV-10AUR ATMEGA644P-20AUR ATMEGA1284-AU ATMEGA1284-AUR ATMEGA324PA-AN ATMEGA324A-AURA3 ATMEGA16-16AU ATMEGA16-16AUA2 ATMEGA16L-8AU ATMEGA16-16AUR ATMEGA16L-8AUR ATMEGA32-16AU ATMEGA32L-8AU ATMEGA32A-AURA5 ATMEGA32L-8AUR ATMEGA164A-AUA2 ATMEGA164PA-AN ATMEGA164PA-ANR ATMEGA164A-AURA2 ATMEGA8515-16AUR ATMEGA8535-16AU ATMEGA8535L-8AU ATMEGA8535-16AUR ATMEGA8535L-8AUR ATMEGA32-16AUA3 ATMEGA32L-8AUA3 ATMEGA32-16AQ ATMEGA32-16AQR ATMEGA32L-8AURA0 ATMEGA32L-8AURA2 ATMEGA32L-8AURA4 ATMEGA164P-20AQ

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ATMEGA164P-20AQRA1

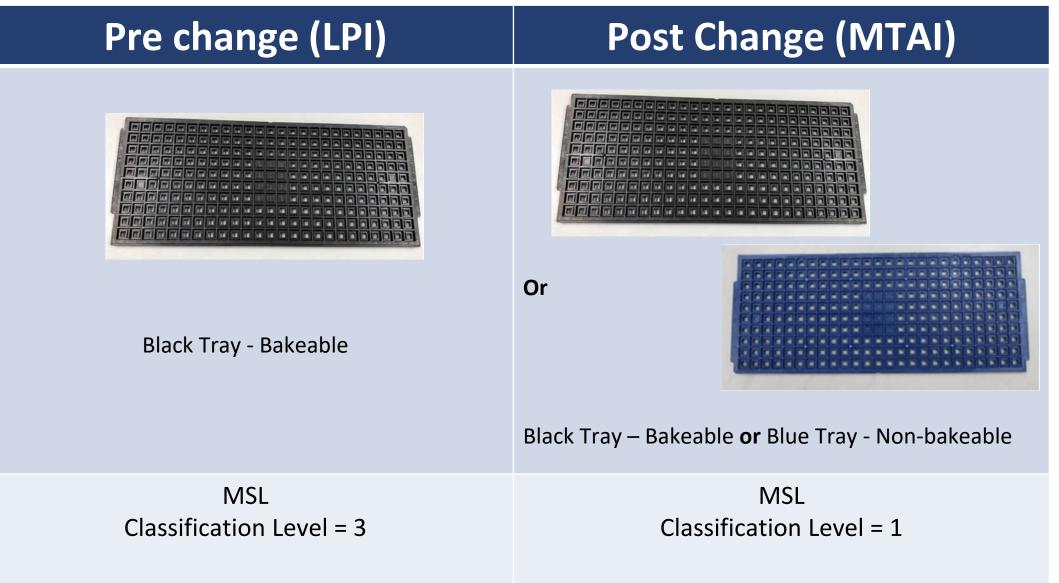
CCB 3296.002 Pre and Post Change Summary PCN#: RMES-23FLBS013



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Tray comparison







QUALIFICATION REPORT SUMMARY RELIABILITY LABORATORY

PCN #: RMES-23FLBS013

Date: June 21, 2022

Qualification of MTAI as an additional assembly site for selected Atmel products available in 44L TQFP 10x10x1mm package. The qualification of MTAI as a new assembly site for selected ATMEGA1284x, ATMEGA16xxx, ATMEGA32xxx, ATMEGA644xx and ATMEGA85x5x device families available in 44L TQFP (10x10x1mm) package will be qualify by similarity (QBS).



Purpose: Qualification of MTAI as an additional assembly site for selected Atmel products available in 44L TQFP 10x10x1mm package. The qualification of MTAI as a new assembly site for selected ATMEGA1284x, ATMEGA16xxx, ATMEGA32xxx, ATMEGA644xx and ATMEGA85x5x device families available in 44L TQFP (10x10x1mm) package will be qualify by similarity (QBS).

	Assembly site	MTAI				
	BD Number	BDM-001705 rev.A				
Mico	MP Code (MPC)	354787T4XC01				
<u>Misc.</u>	Part Number (CPN)	ATMEGA644				
	CCB No.	3296, 3296.001, 3296.002 and 3296.003				
	QTP No. and Rev	3393 Rev A				
	Paddle size	180x180 mils				
	Material	C7025				
	Surface	Bare Cu on paddle				
	Treatment	Roughening				
<u>Lead-Frame</u>	Process	Stamped				
	Lead-lock	No				
	Part Number	10104412				
	Lead Plating	Matte Tin				
Bond Wire	Material	Au				
D : A (()	Part Number	3280				
<u>Die Attach</u>	Conductive	Yes				
<u>Mold</u> Compound	Part Number	G700				
	PKG Type	TQFP				
PKG	Pin/Ball Count	44				
	PKG width/size	10x10 mm				
	MSL	MSL1/260				



Manufacturing Information:

Assembly Lot No.	Wafer No.	Date Code
MTAI184804027.000	MCSO518476707.100	18089QW
MTAI184804028.000	MCSO518476707.100	18089QY
MTAI184804029.000	MCSO518476707.100	18089R0

Result

X Pass

Fail

Atmel 35478 using Au wire in 44L TQFP 10x10 package at MTAI is qualified at Moisture/ Reflow Sensitivity Classification Level 1 per IPC/JEDEC J-STD-020D standard. No delamination were observed on all the units.

	PACKAGE QUALIFICATION REPORT								
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks			
Precondition Prior Perform Reliability Tests (At MSL Level 1)	Electrical Test : +90°C	JESD22- A113	958(0) 135(0)	0/958 0/135	Passed	Good Devices			
	Bake 150°C, 24 hrs System: HERAEUS		958(0)						
	85°C/85%RH Moisture Soak 168 hrs. System: Climats Excal 5423-HE	IPC/JEDE C J-STD- 020D	958(0)						
	3x Convection-Reflow 265°C max System: Mancorp CR.5000F	0200	958(0) 135(0)	0/135	Passed				
	Electrical Test :+90°C		958(0)	0/958	Passed				
	Stress Condition: (Standard) 65°C to +150°C, 500 Cycles System : VOTSCH VT 7012 S2	JESD22- A104	252			Parts had been pre-conditioned at 260°C			
Temp Cycle	Electrical Test: 90°C, System: MAGNUM05 (Handtest)		252(0)	0/252	Passed				
	Bond Strength: Wire Pull (> 2.50 grams) Bond Shear (>15.00 grams)		15(0)	0/15	Passed				
UNBIASED-	Stress Condition: (Standard) +130°C/85%RH, 96 hrs. System: HIRAYAMA HASTEST PC-422R8	JESD22- A118	252			Parts had been pre-conditioned at 260°C			
HAST	Electrical Test: +90°C System: MT9510 Handler:2580		252(0)	0/252	Passed				

PACKAGE QUALIFIC	CATION	I REF	PORT		
Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Stress Condition: (Standard) +130°C/85%RH, 96 hrs. Bias Volt: 5.5 Volts System: HIRAYAMA HASTEST PC-422R8 Electrical Test:+90°C System: MT9510 Handler:2580	JESD22- A110	250 250(0)	0/250	Passed	Parts had been pre-conditioned at 260°C
Stress Condition: Bake 175°C, 504 hrs System: HERAEUS Electrical Test :+90°C	JESD22- A103	50 50(0)	0/50	Passed	50 units
Bake: Temp 155°C,4Hrs System:Oven Solder Bath: Temp.245°C Solder material: SnPb Visual Inspection: External Visual Inspection	JESD22B- 102E	15 (0)	0/15	Passed	Performed at MPHIL
Wire Pull (> 2.50 grams) Bond Shear (>15.00 grams)	M2011.8 MIL-STD- 883 M2011.8 MIL-STD- 883	30(0) Wires 30(0) Wires		Passed	
	Test ConditionStress Condition: (Standard) +130°C/85%RH, 96 hrs. Bias Volt: 5.5 Volts System: HIRAYAMA HASTEST PC-422R8Electrical Test:+90°C System: MT9510 Handler:2580Stress Condition: Bake 175°C, 504 hrs System: HERAEUSElectrical Test :+90°CBake: Temp 155°C,4Hrs System:Oven Solder Bath: Temp.245°C Solder material: SnPb Visual Inspection: External Visual InspectionWire Pull (> 2.50 grams)	Test ConditionStandard/ MethodStress Condition: (Standard) +130°C/85%RH, 96 hrs. Bias Volt: 5.5 Volts System: HIRAYAMA HASTEST PC-422R8JESD22- A110Electrical Test:+90°C System: MT9510 Handler:2580JESD22- A103Stress Condition: Bake 175°C, 504 hrs System: HERAEUSJESD22- A103Electrical Test :+90°CJESD22- A103Bake: Temp 155°C,4Hrs System:Oven Solder Bath: Temp.245°C Solder material: SnPb Visual Inspection: External Visual InspectionJESD22B- 102EWire Pull (> 2.50 grams)M2011.8 MIL-STD- 883Bond Shear (>15.00 grams)M2011.8 MIL-STD-	Test ConditionStandard/ MethodQty. (Acc.)Stress Condition: (Standard) +130°C/85%RH, 96 hrs. Bias Volt: 5.5 	Test ConditionStandard/ MethodQty. (Acc.)Def/SS.Stress Condition: (Standard) +130°C/85%RH, 96 hrs. Bias Volt: 5.5 Volts System: HIRAYAMA HASTEST PC-422R8JESD22- A110250Electrical Test:+90°C System: MT9510 Handler:2580250(0)0/250Stress Condition: Bake 175°C, 504 hrs System: HERAEUSJESD22- A10350Electrical Test :+90°CJESD22- A10350(0)0/50Bake: Temp 155°C, 4Hrs System: Oven Solder Bath: Temp.245°C Solder material: SnPb Visual InspectionJESD22B- 102E15 (0)0/15Wire Pull (> 2.50 grams)M2011.8 MIL-STD- 88330(0) Wires30(0) Wires	Method(Acc.)(Acc.)Stress Condition: (Standard) +130°C/85%RH, 96 hrs. Bias Volt: 5.5 Volts System: HIRAYAMA HASTEST PC-422R8JESD22- A1102500/250PassedElectrical Test:+90°C System: MT9510 Handler:2580JESD22- A103250(0)0/250PassedStress Condition: Bake 175°C, 504 hrs System: HERAEUSJESD22- A103500/250PassedElectrical Test:+90°CJESD22- A10350(0)0/50PassedBake: Temp 155°C,4Hrs System:Oven Solder Bath: Temp.245°C Solder material: SNPb Visual Inspection: External Visual InspectionJESD22B- 102E15 (0)0/15PassedWire Pull (> 2.50 grams)M2011.8 MIL-STD- 88330(0) Wires30(0) WiresPassed